

HP M9195A

## PXle Digital Stimulus/Response Module



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Keysight Technologies

# M9195B PXIe Digital Stimulus/Response with PPMU: 250 MHz, 16-channel

Data Sheet



## Overview

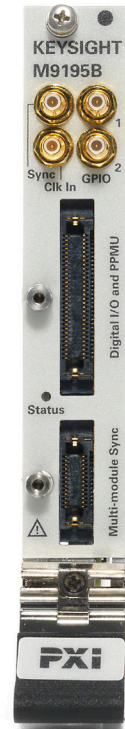
Experience high speed digital test capabilities at a whole new level. The Keysight Technologies, Inc. M9195B PXIe Digital Stimulus/Response (PXI DSR) module is ideal for IC design validation and production test environments. It goes beyond providing just standard capabilities. The new 16-channel, single slot PXI module introduces a high performance pattern cyclizer for powerful pattern creation including advanced timing capabilities such as multiple drive edges per cycle. This provides flexible edge placement and stimulus/response delays for timing margin testing or cable length compensation. Additionally, it can support up to four independent multi-sites with an independent sequencer for each site.

Software tools included with the M9195B allow the user to modify vector and pattern parameters without requiring the user to recompile and download tests. An optional set of digital development tools are also available. These software tools include a graphical pattern editor and pattern conversion tools to speed test development by enabling test patterns from various EDA systems to be read in, edited, and output to the M9195B.

Additional ATE features include:

- High speed pattern application and RZ (Return-to-Zero) clock rate up to 250 MHz
- Per pin programming of voltage levels
- Real time compare, parametric measurement unit (PPMU)
- Deep vector memory and flexible pattern sequencing

With the PXI DSR module you can easily emulate standard serial interfaces like the MIPI® RF Front-End interface or proprietary parallel device interfaces. The test development software tools enable you to quickly create and edit waveform patterns or to import patterns created by automatic test generation applications.



## Applications

- RFFE bus emulation used in PA/FEM semiconductor device verification or production test
- Wireless communication devices using parallel or serial digital control
- Automated test in product validation or manufacturing test
- Backplane emulation for device, board, or module testing
- Digital serial and parallel applications

## Key features

- Combine modules to form systems of up to 192 channels (requires option MMS).
- 16 bidirectional channels with per-pin programmable logic levels
- Highly flexible, per-bit timing control for fast and accurate waveform development
- Reconfigurable per-pin Parametric Measurement Unit (PPMU) for each channel
- Single and multi-site configurations
- Edit patterns on-the-fly without recompiling and downloading the test
- Execute patterns in arbitrary order
- Flexible allocation of deep pattern memory per channel or per site to allocate memory where it is needed
- Channel delay adjustment to compensate for cable and fixture propagation delays
- 4 high voltage channels for flash programming or fuse test
- 4 open drain auxiliary output pins for fixture relays
- Hardware triggers and markers for test system synchronization
- Comprehensive software tool set for quick test development

## M9195B hardware overview

### Individual channel capability

Each of the 16 bidirectional channels provide programmable logic levels of  $-1.5\text{ V}$  to  $+6.5\text{ V}$  with  $152\text{ }\mu\text{V}$  resolution. The per channel 4 quadrant parametric measurement unit (PPMU) enables FVMI, FIMV, FVMV, and FIMI and FNMV modes. With the 5 PPMU current ranges between  $\pm 2\text{ }\mu\text{A}$  to  $\pm 40\text{ mA}$ , users can make accurate leakage measurements.

Each channel can be configured for parametric measurements, as a static digital I/O pin, or with synchronized cyclized digital data. Digital channel direction and timing can be flexibly controlled on a per digital vector basis. The cyclized data allows each pin to operate in RZ or NRZ modes. In combination with the  $1\text{ ns}$  edge placement resolution, each pin allows for an adjustable output delay, for timing margin testing, and receive delay to compensate for cabling propagation delays.

### Multi-site capability

The PXI DSR provides a choice of a single-site configuration with 16 synchronized channels, or a multi-site configuration with 4 sets of 4 synchronized channels. In multi-site mode, each site has its own independent sequencer. This enables site independent clock operation for simultaneous testing. The multi-site capability simplifies test development. Instead of forcing the test engineer to create a single test that encompasses all for sites simultaneously, the user only needs to focus on a single device. The single device test can be easily replicated for the remaining test sites. In addition to the digital pins, each site has a high voltage drive channel and an open drain control channel for relay control.

### Multi-module synchronization

Up to 12 modules can be combined to build systems up to 192 channels (requires opt MMS for each module plus the appropriate sync cable, either Y1250A or Y1251A). When modules are combined, they operate in single-site mode and all channels are synchronized to a single test sequencer. Typical channel-to-channel skew (including across modules) is  $\pm 300\text{ ps}$ . Multiple modules are combined and programmed together into a single multi-module instrument.

### Per-Pin Parametric Measurement Unit (PPMU)

The PPMU feature, available on each of the PXI DSR's 16 channels, enables DC current and voltage measurements. Each channel can be independently programmed to force a voltage and measure the corresponding current, or force a current and measure the voltage. The PPMU can make leakage current measurements at low current ranges or for measuring low input resistance in high current ranges. In a force voltage/measure current (FVMI) mode the PPMU can measure input bias current on a single DUT pin. For high current applications, each channel has remote sense capability to account for the voltage drop across the connecting cable.

Perform continuity testing of a DUT by forcing current into the pin with other DUT pins grounded while measuring the voltage at the pin (FIMV). The FNMV mode (Force Nothing, Measure Voltage) enables the PPMU to be used as a scanning voltmeter. The PPMU provides built-in 64 sample, 50 Hz or 60 Hz averaging to improve measurement quality by rejecting power line noise. All PPMU channels share a 16-bit measurement subsystem for fast accurate measurements.



## Flexible digital pattern generation

With the included software tools, easily create, modify and reuse previously defined patterns. Pattern timing is controlled using up to 32 waveform tables. Within the waveform table, each of the 15 user-defined vector characters is translated into one of the following hardware actions: Force High/Low (U/D), Force to previous state (P), Stop Forcing (Z), Compare High/Low (H/L), Compare to Tri-state (T), Don't Compare (X). Each vector period has two drive edges that are used when forcing a digital state and one receive edge used to compare digital data from the DUT. Edge placement resolution can be set as low as 1 ns and edge placement can vary from period to period so that oversampling is not required. The two drive edges enable the user to easily create a clock or other RZ formats from a single vector without requiring two vectors. The flexibility of the drive edges allow them to be changed on a per vector basis using the vector characters or by referencing a different waveform table.

The combination of the waveform tables and edge placement resolution simplifies the pattern programming. Variables and equations can be defined to allow the user to simultaneously modify timing relationships and edge placement.

Once compiled, the digital patterns are stored in the PXI DSR's on-board pattern cache. The PXI DSR executes the patterns from the cache in order to provide high test throughput. High-level pattern sequencing commands allow for high level macros which can be used to define timing sets, counted and uncounted looping of pattern blocks, conditional execution based upon matching parallel or serial patterns, or wait for software trigger advance.

## Advance timing capabilities

Change pattern values that have been downloaded to the cache without recompiling. Pattern values can replace either parallel vectors or serial patterns. These powerful features allow you to quickly modify patterns directly from the API. The user can create pattern templates that are used to read or write to the DUT, then provide the vector information directly from the API.

Variables can be modified at the API level without recompiling the test pattern. This allows the user to control pattern timing or levels directly from the API. These advanced capabilities useful for test applications such as a timing or voltage level shmoo.

## Serial and parallel digital bus emulation

The combination of the flexible pattern timing and sequencing features, enables the PXI DSR to emulate a wide variety of standard or custom serial/parallel protocols such as SPI and RFFE.

## Comprehensive software tool set

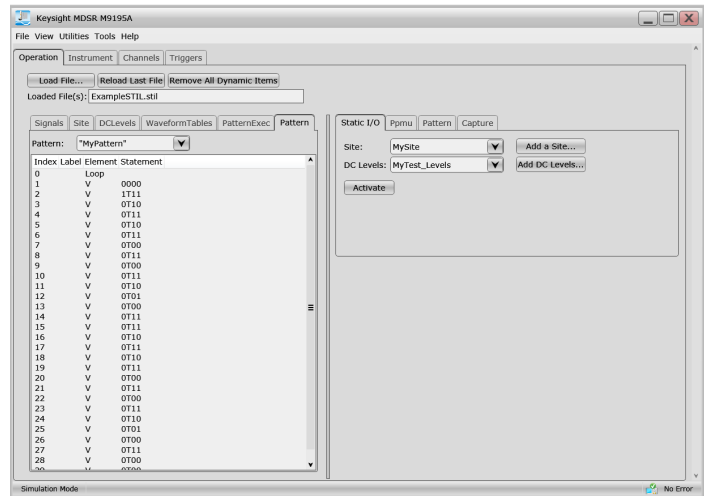
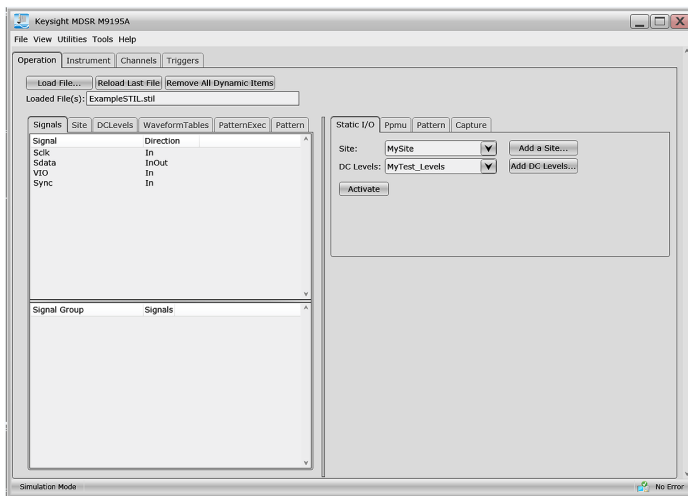
Keysight offers a choice of drivers and programming environments to configure and control the PXI DSR during test development including:

- Full featured, high-level IVI-COM, IVI-C, LabVIEW programming interfaces through drivers
- IEEE-1450/ STIL, OpenXML (Excel), or text file format for programmatically defining patterns
- The M9195B Soft Front Panel for interactive test control and debug
- The M9192A/M9193A DSR pattern editor and data converters software enable test patterns from various EDA systems to be read in, edited, and output to the M9195B

These test development tools can be used in powerful combinations to match the DUT's test flow and test requirements.

### Soft Front Panel (SFP)

The SFP assists the user in the development and application of test patterns, allows the user to change key test execution parameters, and allows the user to validate and compensate for test fixture connectivity. During pattern development, the user interactively loads and execute STIL, XML, or bulk data files. When loading, the tests are checked for correct syntax and the SFP generates error messages to help debug patterns. The SFP enables the user to the control various execution and response logging modes. In addition to these features, the SFP uses the same IVI interface driver calls. Each function initiated by the SFP logs an example driver call that can then be used in a regular API environment.



### IVI and LabVIEW drivers

The IVI driver set can be used to fully control all aspects of test development using the DSR from assigning hardware pins to creating and executing waveform patterns using the M9195B. The drivers include high level commands for:

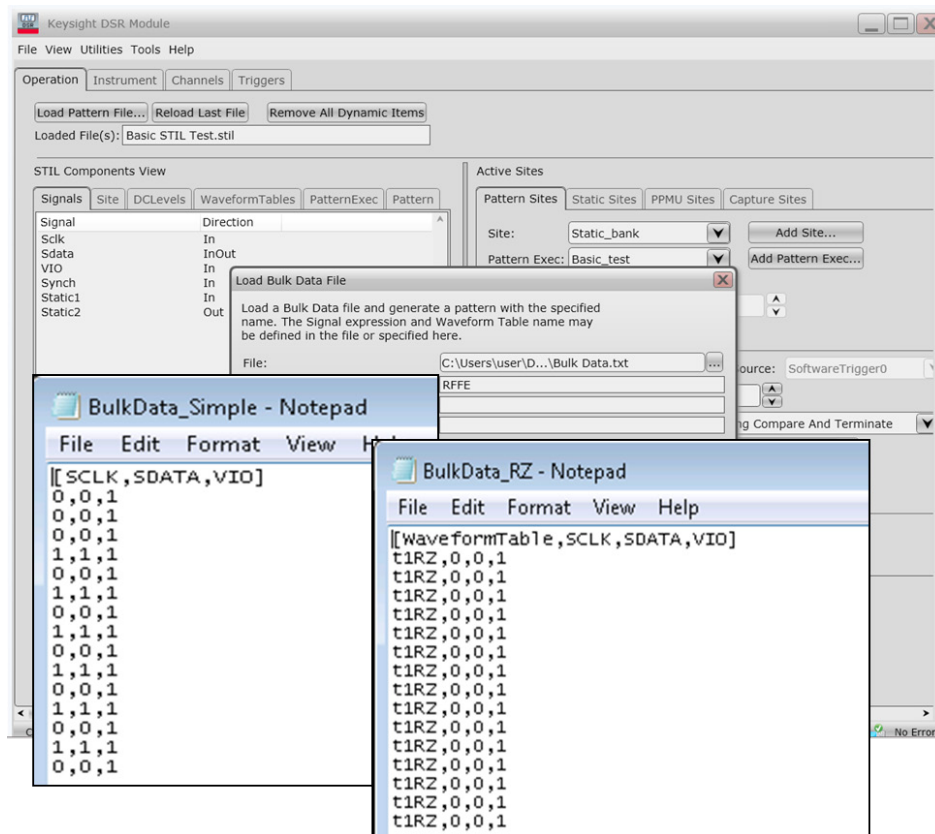
- Initial configuration including pin/channel names assignments, signal direction, grouping pins/channels to make vector definition easier.
- Setting physical layer conditions such as voltage levels, active loads
- Defining single or multisite configurations.
- Pattern definition and waveform timing.
- Pattern sequencing

## Standard Test Interface Language (STIL) Support

The PXI DSR takes advantage of the Standard Test Interface language (STIL) IEEE Std 1450.0 which was designed for ATE testing. The PXI DSR can be configured using STIL commands that specify signal grouping, patterns, format, and timing information used to apply digital test vectors to a device being tested. Using a simple text editor and using the STIL format, attributes needed to generate digital patterns can quickly be created. STIL tests are easy to read and understand which simplifies test development and debug. Either the IVI API or the SFP can execute tests developed in STIL.

## Bulk data import

The PXI DSR supports bulk data file import to load legacy and tool generated patterns. Bulk data import utilizes simple text files where the first row contains signal names and provides the option to a reference a waveform table. Each subsequent row represents the vectors which make up the patterns. The waveform table itself can be defined using the SFP, IVI driver, or STIL file. This provides a quick and easy way to develop production tests using patterns developed in R&D.



## XML (.xlsx) programming interface

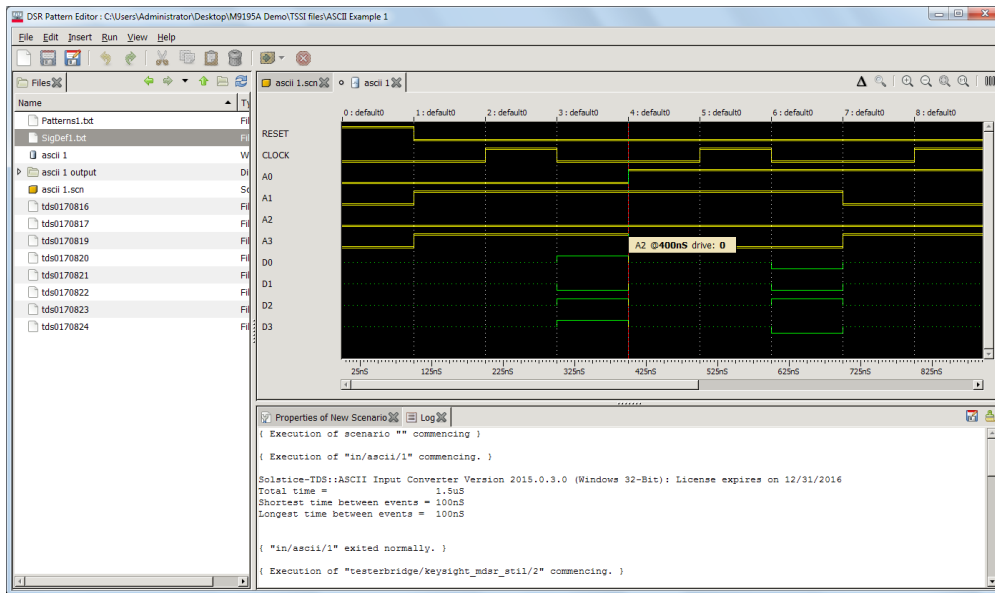
The XML interface allows the user to develop and debug tests in a spreadsheet form. The STIL methodology fits well with the multiple worksheet concepts provided in modern spreadsheet tools. Each worksheet matches a STIL function such as Signals, Waveform Tables, and Patterns. Digital patterns are tabular in nature and therefore fit very well into a spreadsheet. The spreadsheet provides an easy to use, flexible, and familiar interface for novice or expert users to quickly develop digital tests. All of the standard spreadsheet tools, such as equations, are available to help with pattern creation. This spreadsheet interface can be used to configure and control the M9195B channels and key features is provided as a standard development tool. Spreadsheet tests can be executed using either the SFP or associated IVI commands.

DsrExcelExampleE

E9									
fx 1									
	A	B	C	D	E	F	G	H	I
1	Pattern:MyFirstPattern								
2	# This is a basic pattern. Note that several could be reasonably defined								
3	# BTW, double slash for comment is a really bad choice for Excel. Better use something else								
4	#Additional tables would require a PatternBurst block to define the sequence for the patterns.								
5	Index	Control	Out[1]	Out[2]	Out[3]	Out[4]	Out[5]	Out[6]	Out[7]
6	1	Control	1	1	1	1	1	1	1
7	2		X	X	X	X	X	X	X
8	3		0	1	0	0	0	0	0
9	4		0	0	1	0	0	0	0
10	5		0	0	0	1	0	0	0
11	6		0	0	0	0	1	0	0
12	7		0	0	0	0	0	1	0
13	8		GoTo Label1						
14	9		0	0	0	0	0	0	0
15	10		Loop [10]						
16	11	Loop [10]	0	H	H	H	L	L	L
17	12		0	H	H	L	L	L	L
18	13		0	H	L	L	L	L	L
19	14		0	H	L	L	L	L	L
20	15		EndLoop						

## M9192A and M9193A DSR Pattern Editor and Data Converter Software

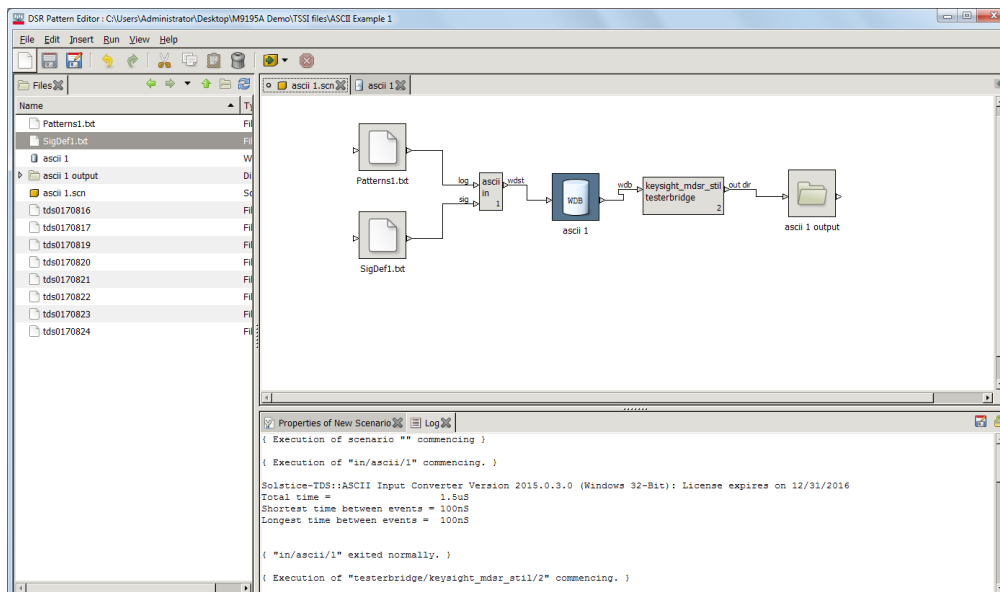
The optional M9192A and M9193A provide a complete set of vector translation and pattern validation software tools for the M9195B. These tools enable design and test engineers to save time, cut costs, and dramatically decrease time to market.



## M9192A DSR pattern editor software

The M9192A DSR pattern editor, based on the Solstice-TDS WaveMaker+ module from Test Systems Strategies Inc. (TSSI), was customized to support the M9195B. The M9192A includes a DSR STIL In-converter, a DSR STIL Tester Bridge, and M9195B error handling. M9195B STIL files can be read using the In-converter and graphically displayed in the pattern editor. Patterns and timing information can then be edited in a single window. This enables you to generate and validate your own test patterns. The modified digital patterns can then be output as a STIL file utilizing the DSR STIL tester bridge. These STIL files can be loaded directly into the M9195B Soft Front Panel or used programmatically.

The pattern editor also speeds up test debug. M9195B error log files can be dragged-and-dropped into waveform editor. This gives immediate visibility of discrepancies between the expected and actual states of the DUT. The digital waveforms can then be edited to ensure a passing test.



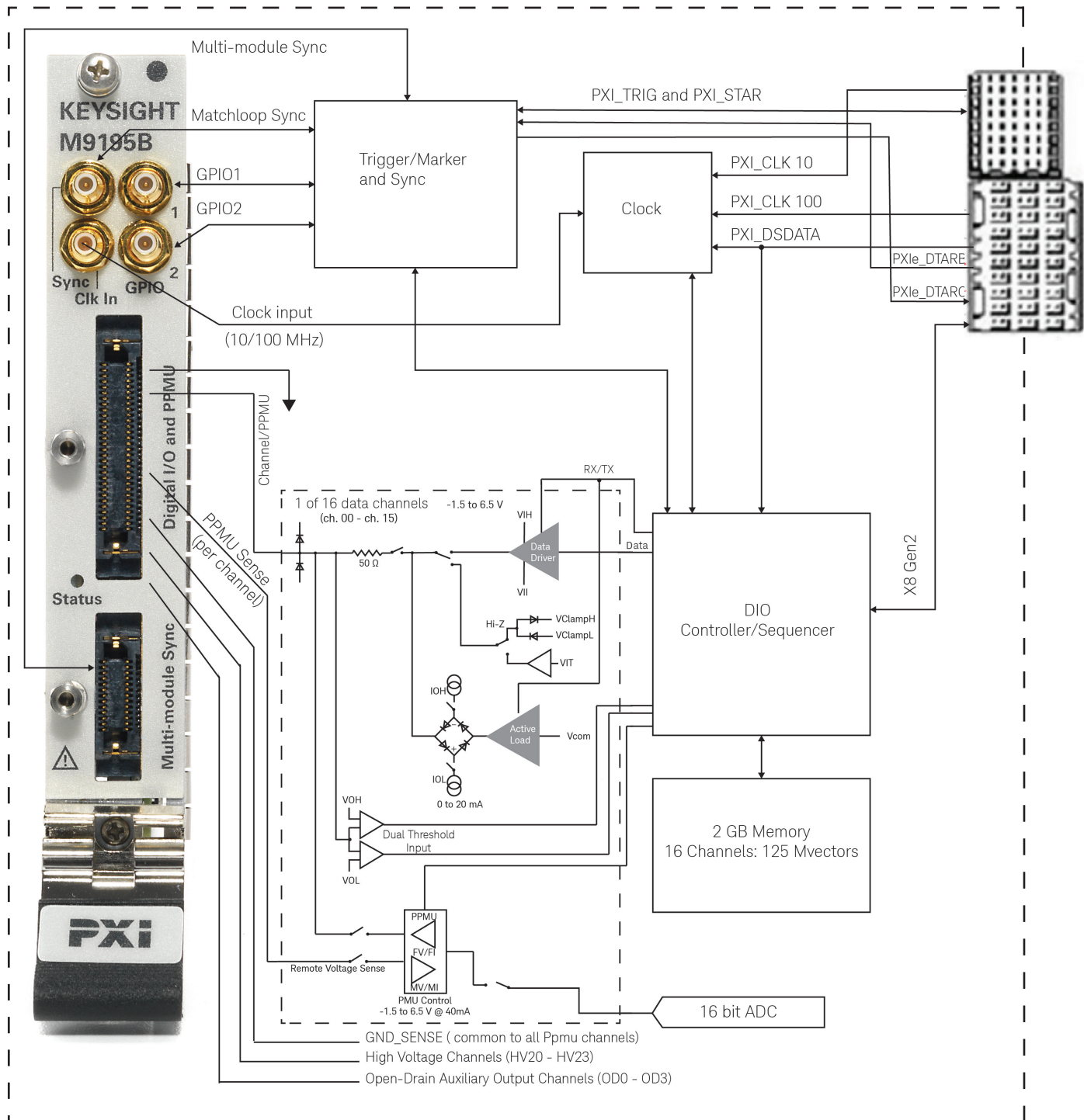
## M9193A DSR Pattern Editor with Data Converters Software

The M9193A DSR pattern editor with data converters combines the digital pattern editor with data converters based on Solstice-TDS In-converters from TSSI. The M9193A enables the utilization of digital pattern files from various Automatic Test Program Generators (ATPGs). Vector files can be read using an appropriate In-converter and then edited using the pattern editor. In the case of Verilog files, an event-based database without timing is created when the VCE/ECVD file is read, and supplied cyclization tools add timing. Once the digital patterns are complete, they can be utilized by the M9195B via the DSR tester bridge. The resulting digital development environment results in fast test development using ATPGs and customized output for the M9195B DSR.

The M9193A includes the following In-converters:

- The WGL In-converter reads an ASCII file that's compliant to the TSSI Waveform Generation Language (WGL) Specification.
- The STIL In-converter reads a text file that is STIL specification compliant (IEEE Std 1450.0-1999). This In-converter is very useful for reading files produced by many ATPGs including Synopsys TetraMAX, Cadence Encounter, and Mentor Graphics FastScan. Note: the M9195B PXIe DSR uses an enhanced version of STIL and is not supported with this STIL In-converter. However, the M9195B is supported with the Keysight DSR STIL In-converter that comes standard with the pattern editor.
- The Verilog In-converter converts a Value Change Dump (VCD) or an Extended Value Change Dump (EVCD) file generated by a Verilog simulator (e.g., Cadence IUS, Mentor Questa, or Synopsys VCS).
- The ASCII In-converter is a flexible, tabular form reader. The TSSI ASCII format is a host-independent, human-readable representation of cyclized test patterns. This format is designed for importing a bulk of data. The bulk data can be created from scratch or by converting from a different pattern format as long as it conforms to the TSSI ASCII format specification. Note: this data format is different than the bulk data format used with the M9195B Soft Front panel.

## Simplified block diagram



## Accessories and cables are designed for easy, accurate, and reliable digital IO connections

### Single-site (16 channels) signal cables

- Y1245A (0.5 meter), Y1246A (1 meter), or Y1247A (2 meter)
- 60 micro coax lines for 16 digital Ch, 16 PPMU sense Ch, 4 high voltage Ch, and 4 open drain/grounds Ch
- Male Edge Rate with squeeze latches or thumb screw hood



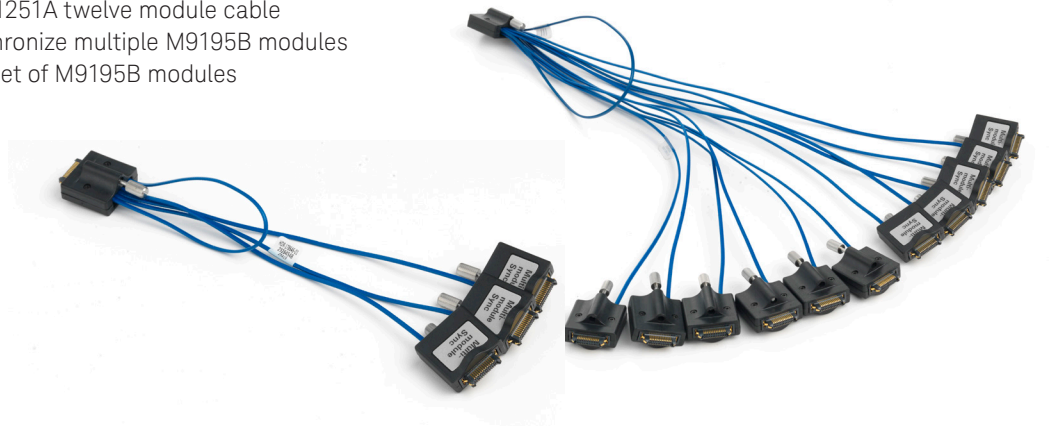
### Multi-site (4 sites of 4 channels) signal cables

- 1248A (1 meter) or Y1249A (2 meter)
- 16 Ch divided into 4 independent partitions (connectors)
- Each partition contains an Edge Rate connector with squeeze latch, 4 digital Ch, 4 PPMU sense Ch, 1 high voltage Ch, and 1 open drain Ch
- 4 alternate thumb screw hoods are also provided for optional use
- Requires option S04



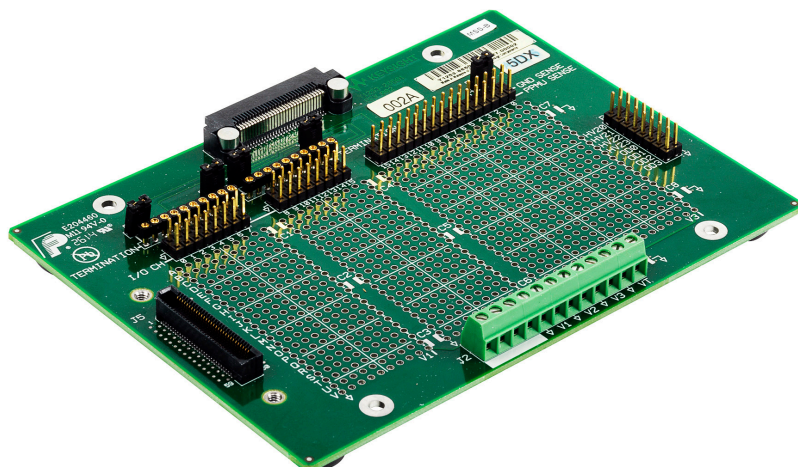
### Multi-module synchronization cables

- Y1250A four module cable or Y1251A twelve module cable
- Used to interconnect and synchronize multiple M9195B modules
- Only one cable is required per set of M9195B modules
- Requires option MMS



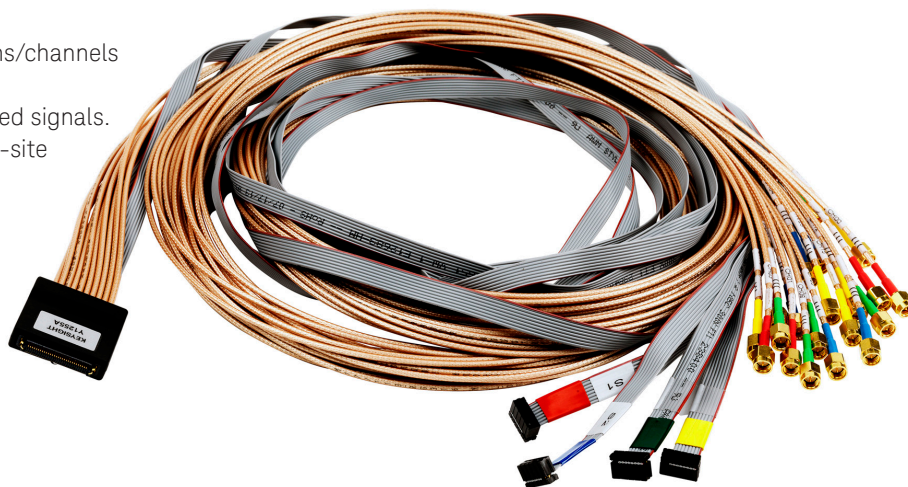
## Evaluation and prototyping board

- Y1253A allows users to access individual signal pins for prototyping or debug.
- Board consists of 1 inch of signal header breakout pins, prototyping area with associated power connector, and signal termination pads.
- Offers 9in2 of bread board area, power/ground, includes headers for 16 channels, 16 PPMU channels high voltage and open drain channels
- The Y1253A proto board is designed for use with the single-site, Y1245A, Y1246A and Y1247A, cables only.



## SMA breakout cables

- Y1254A (1 meter) and Y1255A (2 meter)
- Enables user access to individual signal pins/channels for prototyping or debug
- SMA connectors plus a header for low-speed signals.
- Cables work with both the single and multi-site configurations



## Definitions for specifications and characteristics

Specifications	<p>Warranted performance. Specifications include guardbands to account for the expected statistical performance distribution, measurement uncertainties, and changes in performance due to environmental conditions. All specifications and characteristics apply over the operating environment outlined in “Environmental and Regulatory” section of this data sheet. In addition, the following conditions must be met:</p> <ul style="list-style-type: none"> <li>– Instrument has been turned on for 30 minutes with the PXI DSR software running.</li> <li>– Instrument is within its calibration cycle.</li> <li>– Instrument remains at a stable surrounding environment temperature (between 0°C to 45°C) for 1 hour prior to turn-on.</li> </ul> <p>Specifications in this document are identified by an asterisk (*).</p>
Characteristics	A performance parameter that the product is expected to meet before it leaves the factory, but that is not verified in the field and is not covered by the product warranty. A characteristic includes the same guardbands as a specification.
Typical	Expected performance of an average unit at a stable temperature between 20°C to 30°C for 30 minutes prior to turn-on and during operation; does not include guardbands. It is not covered by the product warranty. The instrument must be within its calibration cycle.
Nominal	A general, descriptive term or design parameter. It is not tested, and not covered by the product warranty. Data represented in this document are nominal unless otherwise identified.
Best practices	<p>To ensure proper cooling, use Keysight slot blockers (Y1212A), filler panels (Y1213A), and the air inlet module kit (Y1214A) in the chassis when there are empty slots. Keysight chassis and filler panels optimize module temperature performance.</p> <p>At environmental temperatures &gt; 40 °C, chassis fans should be set to high.</p>
Additional information	<p>All data are measured from multiple units at room temperature and are representative of product performance within the operating temperature range unless otherwise noted.</p> <p>The specifications contained in this document are subject to change.</p>

## Technical specifications and characteristics

<b>General Characteristics</b>	
<b>Module characteristics</b>	
Bus interface & compatibility	PXI Express peripheral module (x1, x4, x8 PCIe® specification v 2.1)
Number of data channels	16, per-channel parametric measurement unit (PPMU)
Number of sites per module	One 16 channel or four 4-channel sites (option dependent)
Maximum data rate for data channels	250 Mbps (option dependent)
Maximum RTZ clock on data channels	250 MHz (option dependent)
Number of high voltage channels	4
Number of auxiliary open drain channels	4
Module memory	2 GB (allocated between pattern, response capture and sequence control)
Maximum number of synchronized modules	12 (requires opt MMS)
Maximum number of synchronized channels	192 (requires opt MMS)
<b>Front panel connectors</b>	
Data , open drain, HV, PPMU sense	ERCD30
Reference clock input (REF CLK IN)	SMB connector
Sync in/out (SYNC)	SMB connector
Trigger in/marker out (GPIO1/2)	SMB connector
<b>Mechanical characteristics</b>	
Dimensions (H x W x D) in mm	3U/1-slot PXIe standard 130.1 x 21.7 x 210 mm; includes connector and handle extensions
Weight	482 g

## Technical specifications and characteristics

DC Power Requirements		
DC supply	Typical	Maximum
DC supply current:		
+3.3 V	3.0 A	4.5 A
+12 V	2.8 A	3.2 A
Power dissipation (max)	44 W	53 W

Data Channel Characteristics		
Characteristic	Value	Comments
<b>* denotes warranted specification</b>		
Number of data channels	16	
Maximum pattern memory	125 Mvectors per channel	Option dependent
Channel type	Single-ended, ground reference	
Channel impedance	50 $\Omega$	Nominal
Direction control (In, Out, In/Out)	Per channel, per cycle (period)	
Per cycle digital states	2 drive states, 1 receive state	
Programmable drive states	Force high, force low, force terminate	Terminate state either drives active termination or is high-Z with reflection clamps
Programmable receive states	Compare high, compare low, compare three-state, compare off	Three-state: a signal level between receive high and receive low thresholds
Programmable voltage setting	Per channel	
Drive/receive voltage range	-1.5 V to +6.5 V (16-bit with 152 $\mu$ V resolution)	VIH – VIL $\geq$ 100 mV VIL (-1.5 V to +6.4 V) VIH (-1.4 V to +6.5 V)
Drive voltage accuracy *	$\pm$ 25 mV (VIH & VIL) DUT centric	DUT centric. Maximum accuracy from $\pm$ 5 °C of AutoCorrections
Receive voltage accuracy *	$\pm$ 20 mV (VOH & VOL) DUT centric	DUT centric. Hysteresis off. Maximum accuracy from $\pm$ 5 °C of AutoCorrections
Channel output short circuit current limit	$\pm$ 75 mA, nominal	Maximum of 250 mA per module in combination with other channels
Channel rise time	<450 ps @ 1 V pp (programmed) <700 ps @ 3 V pp (programmed) <1250 ps @ 6 V pp (programmed)	Into 50 $\Omega$ , 20-80%, typical
Channel fall time	<450 ps @ 1 V pp (programmed) <700 ps @ 3 V pp (programmed) <1250 ps @ 6 V pp (programmed)	Into 50 $\Omega$ , 20-80%, typical
Minimum detectable voltage swing, receive	40 mV	Nominal. Hysteresis off
High impedance current leakage		
– Receive-only channel	$\pm$ 6 nA	Typical. Static or dynamic digital mode
– Receive-only, low leakage mode *	$\pm$ 1.5 nA	Dynamic digital mode only <sup>1</sup>
– Bi-directional channel	$\pm$ 2 $\mu$ A	Typical. Static or dynamic digital mode
Channel power-on state	high-Z	
Receive hysteresis settings	0 mV, 50 mV, 100 mV	
Channel jitter	<25 ps RMS	Typical. EPR <sup>2</sup> = 1 ns
Channel to channel jitter	<25 ps RMS	Typical. EPR <sup>2</sup> = 1 ns

1. The following conditions apply: 0 °C – 30 °C operating range,  $\pm$ 2 °C of measure leakage current, 250 mV of measure leakage voltage ( $\pm$ 1 V range)

2. EPR = Edge Placement Resolution

## Technical specifications and characteristics

Data Channel Characteristics		
Characteristic * denotes warranted specification	Value	Comments
Active termination range	-1.5 V to +6.5 V (16-bit with 152 $\mu$ V resolution)	50 $\Omega$ terminated into VIT
Active termination accuracy *	$\pm 25$ mV (VIT)	Maximum accuracy from $\pm 5$ °C of AutoCorrections
Reflection clamp range	-2 V to +7 V (16-bit with 152 $\mu$ V resolution)	VCH - VCL > 0.8 V VCL (-2 V to +6.2 V) VCH (-1.2 V to +7 V)
Reflection clamp accuracy	$\pm 30$ mV @ 1 mA (VCH & VCL) $\pm 200$ mV @ 10 mA (VCH & VCL) $\pm 400$ mV @ 25 mA (VCH & VCL)	50 $\Omega$ source impedance into clamps. Characteristic accuracy from $\pm 5$ °C of AutoCorrections neglecting source impedance voltage drop
Active load range (IOH & IOL)	0 mA to 25 mA (16-bit with 762 nA resolution)	Maximum of 250 mA per module in combination with other channels
Active load accuracy	$\pm 0.40$ mA (IOH & IOL)	Characteristic accuracy from $\pm 5$ °C of AutoCorrections
Commutation voltage range	-1.5 V to +6.5 V -1 V to +5.5 V	IOL & IOH   $\leq$ 1 mA   IOL & IOH   $\leq$ 25 mA
Commutation voltage accuracy	$\pm 20$ mV (VCOM)	Characteristic accuracy from $\pm 5$ °C of AutoCorrections

High Voltage Channel Characteristics		
Characteristic * denotes warranted specification	Value	Comments
Number of high voltage channels	4	
Channel type	Single-ended, ground referenced	
Channel control	Shared with dependent data channel	Refer to user manual for HV control information HV20 shared with CH 02 HV21 shared with CH 06 HV23 shared with CH 10 HV24 shared with CH 14
Channel impedance	<10 $\Omega$ (when forcing to terminate) 50 $\Omega$ (when forcing High or Low)	Nominal
Channel power-on state	Passive 50 $\Omega$ termination	
Maximum data rate	10 MHz	
Programmable voltage range setting	Per channel	
HV drive range	0 V to +13.5 V (16-bit with 305 $\mu$ V resolution)	Force terminate
HV drive accuracy *	$\pm 40$ mV (VHH)	Maximum accuracy from $\pm 5$ °C of AutoCorrections
Drive voltage range	-0.1 V to +6.5 V (16-bit with 152 $\mu$ V resolution)	Force high or low
Drive voltage accuracy *	$\pm 35$ mV (VIH & VIL)	Maximum accuracy from $\pm 5$ °C of AutoCorrections
HV drive settling time	< 4 $\mu$ s @ 13.5 V pp into 1 M $\Omega$ (1nF) < 350 $\mu$ s @ 13.5 V pp into 1 M $\Omega$ (1nF)	Settled to 1% of final value Typical
HV channel short circuit current limit	$\pm 60$ mA, nominal	Maximum of 250 mA per module in combination with other channels. Nominal

## Technical specifications and characteristics

High Voltage Channel Characteristics		
Characteristic * denotes warranted specification	Value	Comments
Drive rise time	<9 ps @ 1 V pp (programmed) <10 ps @ 3 V pp (programmed) <11 ps @ 6 V pp (programmed)	Into 50 $\Omega$ , 20-80%, Typical
Drive fall time	<9 ps @ 1 V pp (programmed) <10 ps @ 3 V pp (programmed) <11 ps @ 6 V pp (programmed)	Into 50 $\Omega$ , 20-80%, Typical
Drive source/sink current per channel	$\pm 60$ mA, nominal	Maximum of 250 mA per module in combination with other channels
Open Drain Channel Characteristics		
Characteristic	Value	Comments
Number of auxiliary open drain channels	4	
Channel type	Output only, single-ended, ground referenced	
Channel termination	Open drain	Internal 10k $\Omega$ pull-up to +5 V
Sink current per channel	1 A max	Nominal
Channel power-on state	Off	10k $\Omega$ pull-up to +5 V
Maximum working voltage	+ 12 Vdc	
GP-IO Characteristics		
Characteristic * denotes warranted specification	Value	Comments
Number GP-IO channels	2	Trigger In/Marker Out (GPIO 1/2 SMB)
Channel type	Single ended, ground referenced	
Direction control	Per channel	
Channel input impedance	50 $\Omega$ or 10 k $\Omega$	Software selectable, DC coupled
Programmable polarity	Positive or negative slope	
Programmable threshold setting	Per channel	
Input voltage range	-2 to + 5 V	
Programmable input threshold	-2 to + 5 V	
Input threshold accuracy	$\pm 100$ mV	10 k $\Omega$ input impedance
Input minimum pulse width	16 ns	
Input rate	DC to 30 MHz	
Channel output impedance	50 $\Omega$	Marker
Output voltage	3.3 V max (into high-Z) 1.65 V max (into 50 $\Omega$ )	Nominal
Output rate	DC to 100 MHz	
Output rise / fall time	<3 ns	Typical into 50 $\Omega$ , 20%-80%
Source/sink current per channel	$\pm 64$ mA	Nominal

## Technical specifications and characteristics

PPMU Characteristics		
Characteristic	Value	Comments
<b>* denotes warranted specification</b>		
Number of PPMU channels	16	
PPMU modes	Force V measure V, Force V measure I, Force I measure I, Force I measure V, Force nothing measure V	
Measurement averaging modes	None, 64 averages, 50 Hz one PLC, 60 Hz one PLC	
Force voltage range	-2 V to +6.5 V ( $  \text{Current}   \leq 4 \text{ mA}$ ) -2 V to +6 V ( $  \text{Current}   \leq 25 \text{ mA}$ ) -2 V to +5.75 V ( $  \text{Current}   \leq 40 \text{ mA}$ ) (16-bit with 152 $\mu\text{V}$ resolution)	
Force voltage accuracy *	$\pm 10 \text{ mV}$	Maximum accuracy from $\pm 5^\circ\text{C}$ of AutoCorrections. Ground sense tied to ground.
Measure voltage accuracy *	$\pm 10 \text{ mV}$	With remote sense. Maximum accuracy from $\pm 5^\circ\text{C}$ of AutoCorrections with one PLC averaging at sense location. Ground sense tied to ground
Force voltage settling time	< 20 $\mu\text{S}$ (40 mA range) < 20 $\mu\text{S}$ (1 mA range) < 25 $\mu\text{S}$ (100 $\mu\text{A}$ range) < 100 $\mu\text{S}$ (10 $\mu\text{A}$ range) < 525 $\mu\text{S}$ (2 $\mu\text{A}$ range)	1 V rising and falling step settled to 1% of final value into 1 $\text{M}\Omega$ / 1nF load. Typical
Force voltage stability	Stable at all ranges into 1 $\mu\text{F}$	Larger load capacitance possible, but response limited by current slew rate.
Current range	-40 mA to + 40 mA (16-bit with 2.44 $\mu\text{A}$ resolution)	Maximum of 250 mA per module in combination with other channels
	-1 mA to + 1 mA (16-bit with 61 nA resolution)	
	-100 $\mu\text{A}$ to + 100 $\mu\text{A}$ (16-bit with 6.1 nA resolution)	
	-10 $\mu\text{A}$ to + 10 $\mu\text{A}$ (16-bit with 610 pA resolution)	
	-2 $\mu\text{A}$ to + 2 $\mu\text{A}$ (16-bit with 122 pA resolution)	
Force current accuracy *	$\pm 1\%$ of range	Maximum accuracy from $\pm 5^\circ\text{C}$ of AutoCorrections. Remote sense disconnected.
Measure current accuracy *	$\pm 1\%$ of range	Maximum accuracy from $\pm 5^\circ\text{C}$ of AutoCorrections with one PLC averaging. Remote sense disconnected.
Force current settling time	Dependent on load	
Channel leakage	$\pm 10 \text{ nA}$	Typical
Remote sense	16 channels 1 GND	Ground sense should be tied to ground at measurement location for maximum accuracy.
Remote sense leakage	$\pm 4 \text{ nA}$	Typical
Force current voltage clamp range	-2 V to +6.5 V (16-bit with 152 $\mu\text{V}$ resolution)	VCH > VCL VCL (-2 V to +4 V) VCH (0 V to +6.5 V)
Force current voltage clamp accuracy	$\pm 50 \text{ mV}$	Characteristic accuracy from $\pm 5^\circ\text{C}$ of AutoCorrections

## Technical specifications and characteristics

Timing and Trigger Characteristics		
Channel clock		
Number of independent clock domains	1 - when configured as a single, 16 channel site 4 - when configured as 4, 4 channel sites	Number of independent clocks depends on the number of sites selected and option
Maximum RZ clock rate on a data channel	250 MHz (option dependent)	
Minimum RZ clock rate on a data channel	5 mHz	
Clock jitter	<25 ps RMS	
Internal reference clock		
Frequency	100 MHz	
Accuracy	±25 ppm	
Period jitter	<2 ps RMS	
Reference clock sources	PXI_CLK100, PXIe-DSTARA, CLK IN	
External reference clock input (SMB front panel)		
Input frequency	10 MHz or 100 MHz	
Input impedance (CLK IN)	50 Ω	Nominal, AC coupled
Input voltage range (CLK IN)	+1.8 V to + 3.3 V	
Lock range accuracy	±25 ppm	
Duty cycle	40 to 60%	
Channel timing (per channel)		
Waveform timing change	Per vector	
Edge placement resolution (EPR)	1 ns minimum	Dependent on waveform table period
Stimulus delay resolution per test: – For EPR ≥ 1 ns and ≤ 1.3 ns – For EPR > 1.3 ns	24 ps EPR	Edge Placement Resolution (EPR) is specified at the time of test activation.
Stimulus delay range per test	254 x EPR	
Response delay compensation resolution per test: – For EPR ≥ 1 ns and ≤ 1.3 ns – For EPR > 1.3 ns	24 ps EPR	Edge Placement Resolution (EPR) is specified at the time of test activation.
Response delay compensation range per test	254 x EPR	
Channel-to-channel skew	±300 ps	Typical, at 1ns EPR
Trigger characteristics		
Trigger sources	Software (API-driven) or Hardware (GPIO1/2, PXI_TRIG0-7, PXI_STAR, and PXIe_DSTAR)	
Waveform characteristics		
Number of waveform tables	32	
Number of waveform characters	15 (user definable)	
Generation waveform iteration count	Once, n times, infinite	
Receive post trigger sampling	0 to full record waveform	

## Technical specifications and characteristics

Environmental Characteristics		
Operating and storage conditions	Operating	Storage
Temperature	0 to 45 °C	–40 to +70 °C
Humidity	Maximum 80% at 40°C (non-condensing)	
Altitude	3,000 meters, de-rate max temperature by 5 °C above 2,000 meters	
Calibration interval	1 year: return to Keysight service center or use Y1252A with N7800A/N7867A	
Mechanical		
Operating vibration	5-500 Hz: 0.21 g RMS, random	
Survival sine vibration	5-500 Hz: 0.5 g (0 to peak), swept sine	
Survival random vibration	5-500 Hz: 2.09 g RMS, random	
Transportation shock	125 G, 8.6 m/s, trapezoidal pulse	
End use handling shock	1.6 m/s, <3 msec duration, half-sine pulse	
Warm-up time	30 minutes	

Samples of this product have been type tested in accordance with the Keysight environmental test manual and verified to be robust against the environmental stresses of storage, transportation and end-use; those stresses include but are not limited to temperature, humidity, shock, vibration, altitude, and power line conditions. Test methods are aligned with IEC 60068-2 and levels are similar to MIL-PRF-28800F Class3.

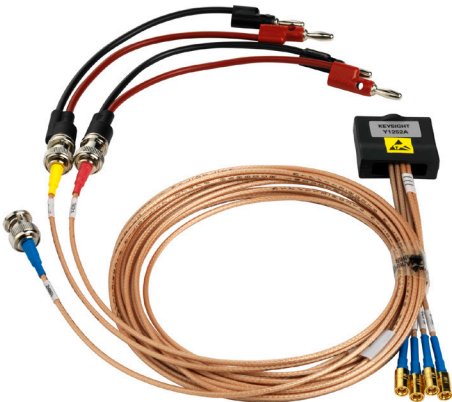
Regulatory
<b>Safety</b>
IEC/ EN 61010-1 USA: ANSI/UL 61010
<b>EMC</b>
IEC 61326-1

## Module calibration

Both adjustment and performance verification is required to calibrate M9195B modules. Self-maintainers can perform these procedures by using software available from Keysight:

- N7800A Test management environment
- N7876A PXI digital IO calibration application

Module adjustment requires the Y1252A adjustment cable. This accessory consists of three cable assemblies necessary for voltage and current adjustments of the M9195B. These cables are used with a high-end digital multimeter (DMM) to adjust on-board analog-digital conversion. The N7876A is required to make adjustments using this cable.



Other instruments and hardware is required for calibration. The N7876A WebHelp file lists the equipment required for adjustment and verification of the M9195B when using the N7800A and N7876A. For more details and access to the N7876A WebHelp file see: <http://cal.software.keysight.com/>.

## Software information

Supported operating systems	Microsoft Windows 7 (32/64-bit)
Standard compliant drivers	IVI-COM, IVI-C, MATLAB
Supported application development environments (ADE)	VisualStudio (VB.NET, C#, C/C++), VEE, LabVIEW, LabWindows/CVI, MATLAB
Keysight IO libraries (16.3 update 2 and 17.1 update 1 or newer)	Includes: VISA libraries, Keysight Connection Expert, IO monitor
Keysight command expert	Instrument control for SCPI or IVI-COM drivers

## Ordering information

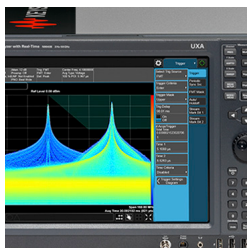
Model	Description
<b>M9195B</b>	<b>PXIe Digital Stimulus/Response with PPMU: 250 MHz, 16 Ch</b>
M9195B-M01	Memory, 16 Mvectors/ch
M9195B-M06	Memory, 64 Mvectors/ch
M9195B-M12	Memory, 125 Mvectors/ch
M9195B-S01	Single site enabled
M9195B-S04	Multi-site enabled
M9195B-SR1	Max clock rate, 125 MHz
M9195B-SR2	Max clock rate, 250 MHz
M9195B-MMS	Multiple module sync
<b>Development software</b>	
M9192A	DSR pattern editor software
M9192A-1TP	Transportable perpetual license (includes 1 year SW updates)
M9192A-1TP-12R	Annual SW updates, 1 year renewal
M9193A	DSR pattern editor with data conversion software
M9193A-1TP	Transportable perpetual license (includes 1 year SW updates)
M9193A-1TP-12R	Annual SW updates, 1 year renewal
<b>Accessories and cables</b>	
Y1245A	Single-site DSR cable: 0.5 m
Y1246A	Single-site DSR cable: 1m
Y1247A	Single-site DSR cable: 2m
Y1248A	Multi-site DSR cable: 1m
Y1249A	Multi-site DSR cable: 2m
Y1250A	Four module sync cable
Y1251A	Twelve module sync cable
Y1252A	DSR adjustment cable
Y1253A	DSR Evaluation and prototyping board
Y1254A	DSR SMA breakout cable: 1m
Y1255A	DSR SMA breakout cable: 2m

## Related products

M9381A PXIe Vector Signal Generator: 1 MHz to 3 GHz or 6 GHz  
 M9393A PXIe Performance Vector Signal Analyzer: 9 kHz to 27 GHz  
 M9371A PXIe Vector Network Analyzer, 300 kHz to 6.5 GHz  
 M9300A PXIe Frequency Reference: 10 MHz and 100 MHz  
 M9018A PXIe 18-Slot Chassis  
 M9037A PXIe High Performance Embedded Controller

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